Enhanced Ferromagnetism in Monolayer Cr₂Te₃ via Topological Insulator Coupling

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Exchange-coupled interfaces are pivotal in exploiting two-dimensional (2D) ferromagnetism. Due to the extraordinary correlations among charge, spin, orbital and lattice degrees of freedom, layered magnetic transition metal chalcogenides (TMCs) bode well for exotic topological phenomena. Here we report the realization of wafer-scale Cr_2Te_3 down to monolayer (ML) on insulating $SrTiO_3(111)$ substrates using molecular beam epitaxy. Robust ferromagnetism emerges in 2D Cr_2Te_3 ML with a Curie temperature $T_C = 17$ K. Moreover, when Cr_2Te_3 is proximitized with topological insulator (TI) (Bi,Sb)₂Te₃, the magnetism becomes stronger – for 1 ML, T_C increases to 30 K, while for 2 ML it boosts from 65 K to 82 K. Our experiments and theory strongly indicate that the Bloembergen-Rowland interaction is likely a universal aspect of T_C enhancement in TI-coupled magnetic heterostructures. The topological-surface-enhanced magnetism in 2D TMC enables further exchange coupling physics and quantum hybrid studies, including paving the way to realize interface-modulated topological electronics.

Magnetism has been at the center of modern information technologies involving sensor, memory and logic devices [1]. Recent development of monolayer (ML) van der Waals (vdW) magnetic materials [2–5], such as FePS₃, CrI₃, Cr₂Ge₂Te₆, Fe₃GeTe₂, VSe₂, MnSe_x, CrSBr and AgCrP₂S₆, have revealed the feasibility of exploiting long-range order and magnetic defects for quantum information storage and processing [6–14]. Utilizing novel vdW magnets, many appealing properties of topological materials, such as large anomalous Hall effect (AHE), topological Hall effect and spin-filtered tunneling effect have been demonstrated [15–17]. Nonetheless, wafer-size ML magnets on insulating substrates, favoring scalability for practical applications, are still much desired.

Among various systems of magnetic transition metal chalcogenides (TMCs), chromium telluride (Cr_2Te_3) thin films are particularly well suited for exploring magnetism towards the ML regime due to its unique crystalline, electronic and magnetic structures [18, 19]. Furthermore, the structural and chemical compatibility allows versatile interfacial modulation, leveraging the salient surface properties when hybridized with Bi_2Te_3 -based topological insulators (TIs) [20].

As shown in Fig. 1a, Cr_2Te_3 crystallizes in a $P\bar{3}1c$ $(D_{3d}^2$, No. 163) structure with perpendicular magnetic anisotropy (PMA) along the crystallographic c axis and a bulk Curie temperature $T_{\rm C}$ of ~ 180 K [21]. Along the c axis, Cr_2Te_3 is composed of alternatively stacked (*i*) ferromagnetic Te-Cr1(Cr2)-Te lamellae similar to those in CrTe₂ [22–25] and (*ii*) weakly antiferromagnetic Cr3 layers [26] with a larger intra-layer Cr-Cr distance and often partial occupancy [18]. It can thus be regarded as a quasi-two-dimensional (2D) system [27], and we herein designate the Te-Cr1(Cr2)-Te-Cr3 configuration as a ML.

Here we report the growth of high quality Cr_2Te_3 thin films on insulating $SrTiO_3(111)$ substrates using molecular beam epitaxy (MBE). Incorporating structural, magnetic and transport measurements, we



Figure 1 | Structure of Cr_2Te_3 thin films. a Atomic structure of Cr_2Te_3 , where three different Cr atoms are labeled as Cr1, Cr2, and Cr3, respectively. b-c RHEED patterns along the [100] direction of Cr_2Te_3 , for 1 ML (b) and 20 ML (c) Cr_2Te_3 films grown on $SrTiO_3(111)$, respectively. d HRSTEM HAADF image of Cr_2Te_3 on $SrTiO_3$ for the (100) plane.

have demonstrated that the ferromagnetism in Cr_2Te_3 prevails down to 1 ML. The ordering strength in turn is amplified by exchange coupling to a TI, leading to an increased $T_{\rm C}$. Our theoretical modeling further corroborates that topological surface states of TI are effective in stabilizing interfacial spin textures with boosted magnetic ordering, serving as a *general* strategy for enhancing $T_{\rm C}$ in 2D vdW magnetic systems.

Structure and physical properties.

 Cr_2Te_3 films were grown on insulating $SrTiO_3(111)$ substrates. The streaky *in situ* reflection high energy electron diffraction (RHEED) patterns shown in Fig. 1b,c indicate the 2D layered growth of the films down to 1 ML. The typical X-ray diffraction (XRD) patterns (shown in Supplementary Fig. 1) reveal good crystallinity of Cr_2Te_3 films on $SrTiO_3(111)$ substrates and are consistent with previously reported Cr_2Te_3 results [18, 28, 29]. The bulk (for film with thickness t = 100 ML) lattice constants were obtained as $a_{XRD} = 6.686 (\pm 0.007)$ Å and $c_{XRD} = 12.164 (\pm 0.003)$ Å.

A sharp and flat interface between the film and the substrate is evident, as illustrated in the high-resolution scanning transmission electron microscopy (HRSTEM) high-angle annular dark-field (HAADF) image (Fig. 1d and Supplementary Fig. 2). The well-resolved region with darker contrast between Te-Cr1(Cr2)-Te trilayers corresponds to the Cr3 sites. The Raman spectra are found to display at least six phonon peaks that are independent of the polarization angle with respect to the crystal axes, consistent with the Cr₂Te₃ phase (Supplementary Fig. 3) [30]. Measurements were performed on multiple spots across the film to verify the long-range uniformity (as also seen in magnetic force microscopy in Supplementary Fig. 3).

The thickness- and temperature-dependent longitudinal electrical resistivity $\rho_{xx}(T)$ of Cr₂Te₃ reveal that thick (t = 100 ML) Cr₂Te₃ film is metallic at ambient temperature and displays a metal-insulator transition (MIT) like behavior at $T_{\text{MIT}} = 8$ K (Fig. 2a). The inflec-



Figure 2 | Transport properties of Cr_2Te_3 thin films. a Longitudinal electrical resistivity ρ_{xx} normalized to values at 300 K of Cr_2Te_3 films with thickness t = 1 - 100 ML. The inset is the schematic film structure. **b** The Hall traces ρ_{yx} of Cr_2Te_3 films with selected t = 1 - 100 ML at 2 K. The 1 ML* data were taken from 4 QL (Bi,Sb)₂Te₃/1 ML $\text{Cr}_2\text{Te}_3/\text{SrTiO}_3(111)$. For better visibility, data for 2 ML and 5 - 100 ML were magnified ×10 and ×50, respectively.

tion point increases logarithmically at reduced thickness and exceeds 300 K for t = 1 and 2 ML. Moreover, upon reducing thickness, ρ_{xx} at room temperature increases in magnitude (see Supplementary Fig. 4). Since it becomes too insulating to measure at low temperature, for the Hall experiments (Fig. 2b), the signal for t = 1 ML was collected by probing the transport in a proximitized TI of 4 quintuple layer (QL) (Bi_{0.23}Sb_{0.77})₂Te₃ (BST) on top (labeled as 1 ML*).

The clear AHE hysteresis in the Hall resistivity $\rho_{yx}(H)$ for all t ranging from 1 to 100 ML, with magnetic field H applied perpendicular to the *ab* basal plane, unambiguously demonstrates the existence of ferromagnetism all the way down to 1 ML. The hysteresis in $\rho_{yx}(H)$ originates from the magnetization M(H) of Cr_2Te_3 . The remanent magnetization and/or Hall resistivity at zero field attest to the long-range ferromagnetic order, which disappears upon warming above $T_{\rm C}$.

At the lowest measured T = 2 K, while the anomalous



Figure 3 | Magnetic properties of $\operatorname{Cr}_2\operatorname{Te}_3$ thin films. a Two-component characteristics of the field-dependent anomalous Hall resistivity ρ_{yx} and **b** out-of-plane magnetization Mfor t = 20 ML at 50 K, as corroborated by **c** the depth profiles of X-ray, PNR nuclear (NSLD) and magnetic (MSLD) scattering length densities (SLD) for t = 26 ML at 100 K. The MSLD data were collected at in-plane field 1 T, 0.8 T, then 0.005 T and 0.39 T (marked as "negative", meaning after a negative saturation at -1 T), corresponding to the typical locations labeled by the asterisks in the hysteresis loop in **b**. The arrows in **a-b** depict the field sweeping directions.

Hall resistivity ρ_{yx}^{AH} (defined as the zero field ρ_{yx} value after fully saturated at positive H) is positive for the thinnest films, it changes sign to negative for t > 6 ML, while the ordinary Hall effect forming the linear background maintains the same positive sign for all t. In addition, for intermediate thicknesses, e.g., t = 6, 10 (Fig. 2b) and 20 ML (Fig. 3a), $\rho_{yx}(H)$ develops a notable hump feature at around the coercive field H_c during the magnetic moment reversal process. Further increase in thickness renders bulk dominating over interface effects, recovering a square-like hysteresis in $\rho_{yx}(H)$ for t = 100 ML. The manifestation of AHE sign reversal, hump-shaped Hall and zero-field kinked magnetization measured via vibrating sample magnetometry (VSM, Fig. 3b) is known to be resultant from the interface strain modulated competition of two channels with different Berry curvatures (that dictate the intrinsic ρ_{ux}^{AH}) and magnetic anisotropies [18].

The Cr₂Te₃ films have magnetic layers with different anisotropies, as corroborated by the depth-sensitive polarized neutron reflectometry (PNR) investigations performed on a typical t = 26 ML sample at T =100 K. As shown in Fig. 3c, the depth profile of the nuclear scattering length density (NSLD) is overall uniform, attesting to the high quality and homogeneous distribution across the thickness of the film. The magnetic scattering length density (MSLD) profiles were collected under in-plane (IP) fields of $\mu_0 H = 1$ T and 0.8 T, then 0.005 T and 0.39 T after sweeping to -1 T. These chosen magnetic fields correspond to the typical positions in the hysteresis loop as labeled by the asterisks in Fig. 3b. A non-uniform depth-dependent profile with two distinct regions is evident, displaying a lower in-plane magnetization value near the substrate. Considering that the PNR experiments are responsive to the in-plane magnetization vector, the observation indicates the stronger strain at the film/substrate interface induces a higher PMA, and as a result, a lower in-plane MSLD value.

Monolayer magnetism and its tunability.

VSM measurements were carried out to probe the magnetic ordering of Cr_2Te_3 . For 1 ML Cr_2Te_3 , the Q factor (defined as the ratio of the uniaxial anisotropy K_u and the shape anisotropy $K_d = 2\pi M^2$) is ~ 1 by comparing the hysteresis loops under out-of-plane (OOP) and inplane field sweeps in Fig. 4a. This indicates comparable out-of-plane and in-plane anisotropies for t = 1 ML in the 2D limit. For 1 ML Cr_2Te_3 , it is estimated that T_C = 17 (±3) K, as judged from the onset in the field-cooled (FC) M(T) curves in Fig. 5c.

PNR was invoked to examine the ferromagnetism of Cr_2Te_3 ultrathin films in the ML regime. The depthsensitive PNR experiments were carried out on a 2 ML Cr_2Te_3 sample, where this thicker t was chosen and necessary for better signal counts. The spin asymmetry (SA) ratio = $(R^+ - R^-)/(R^+ + R^-)$ was measured as a function of the wave vector transfer $Q = 4\pi \sin(\theta)/\lambda$, where R^+ and R^- are the reflectivity for the neutron spin parallel (+) or antiparallel (-) to the applied magnetic field, respectively. As shown in Fig. 4b, the non-zero SA substantiates the emergence of magnetization. By refining the PNR data, the depth profiles of NSLD and MSLD were obtained and are depicted in Fig. 4c. The small yet clear presence of the MSLD profile with measured M =37 emu cm⁻³ at T = 5 K with in-plane $\mu_0 H = 1$ T reveals the high quality of the magnetic Cr_2Te_3 ultrathin films in the ML regime with well-resolved interfacial roughness on the order of 0.5 nm.

To further investigate the magnetism, especially pertaining to transport of 1 ML Cr₂Te₃, temperature dependent AHE transport experiments were performed in the 4 QL BST/1 ML Cr₂Te₃/SrTiO₃(111) film (1 ML^{*}). As compiled in Fig. 5b, the AHE hysteresis loop becomes stronger towards lower temperature, indicating the TI layer is exchange proximitized by the 1 ML Cr₂Te₃ layer underneath that is ferromagnetic. A large AHE sheet resistivity $\rho_{yx,\text{sheet}}^{AH}$ (= 117 Ω) was observed in the film. In turn, as schematically shown in Fig. 5a, the interfacial hybridization with the topological surface states of the TI further strengthens the magnetic ordering in 1 ML Cr₂Te₃, similarly as Katmis *et al.* reported for the EuS/Bi₂Se₃ system [31–33].

Accordingly, as summarized in Fig. 5d, the temperature dependences of $\rho_{yx,\rm sheet}^{\rm AH}$ and $H_{\rm c}$ uncover the strengthened magnetism with an enhanced $T_{\rm C}=$



Figure 4 | Ferromagnetism of $\operatorname{Cr}_2\operatorname{Te}_3$ films in the monolayer regime. a Field dependent magnetization of 1 ML Cr₂Te₃ under out-of-plane (OOP) and in-plane (IP) configurations, respectively. b PNR spin asymmetry ratio SA = $(R^+ - R^-)/(R^+ + R^-)$ at T = 5 K and IP $\mu_0 H = 1$ T. c Depth profiles of PNR nuclear (NSLD) and magnetic (MSLD, with IP $\mu_0 H = 1$ T at 5 K) scattering length densities of 2 ML Cr₂Te₃ on SrTiO₃(111) substrate with Te/AlO_x capping.

30 (±3) K for the 1 ML Cr_2Te_3 in the bilayer system. Further control experiments carried out on 2 ML Cr_2Te_3 substantiate the effectiveness and robustness of the proximity exchange enhanced ferromagnetism when coupled with a TI. As shown in Fig. 5e-h, the hysteresis loops of 2 ML Cr_2Te_3 manifest a $T_C = 65 (\pm 5)$ K, while enhanced ferromagnetism with a higher $T_C = 82 (\pm 5)$ K is achieved when heterostructured with the 4 QL BST.

These experimental observations collectively suggest that atomically thin Cr_2Te_3 layers as an appealing ferromagnetic insulator candidate, displaying interface tunable 2D magnetism suitable for implementing exchange-coupled vdW spintronics.

Topological surface-mediated exchange coupling.

To gain insight into magnetic ordering at the Cr_2Te_3/TI interface, the enhancement of T_C and PMA, we construct a model Hamiltonian $H = H_0 + H_{int}$, where H_0 is the kinetic energy of electrons in the 2D topological surface states of the 3D TI (BST), and H_{int} is the Kondo or *s*-*d* interaction between these electrons and localized Cr moments in Cr_2Te_3 at the interface.

The Dirac Hamiltonian $H_0 = \sum_{\boldsymbol{k},\lambda\lambda'} \hat{c}^{\dagger}_{\boldsymbol{k}\lambda} [\hbar v_{\rm F}(\boldsymbol{k} \times \boldsymbol{\sigma}^{\lambda\lambda'}) \cdot \hat{\mathbf{z}} + \Delta \sigma_z^{\lambda\lambda'}] \hat{c}_{\boldsymbol{k}\lambda'}$ describes the surface state electrons on energy scales less than the bandwidth W. Here $v_{\rm F}$ is the Fermi velocity, \boldsymbol{k} is the in-plane momentum, $\boldsymbol{\sigma}$'s are the spin Pauli matrices, $\hat{\mathbf{z}}$ is the unit vector normal to the surface, λ, λ' are spin labels, and Δ is the exchange gap due to broken time-reversal symmetry at the interface. $H_{\rm int} = J_{\rm K} \sum_{i,\lambda\lambda'} \mathbf{S}_i \cdot \hat{c}^{\dagger}_{i\lambda} \boldsymbol{\sigma}^{\lambda\lambda'} \hat{c}_{i\lambda'}$ characterizes the Kondo coupling $J_{\rm K}$ (with units of energy \times area) between a local moment \mathbf{S}_i at \mathbf{R}_i and the surface state electron spin.

Our first goal is to obtain the effective Hamiltonian

$$H_{\rm eff} = -\frac{1}{2} \sum_{ij,\alpha\beta} J_{\alpha\beta}(\mathbf{R}_{ij}) S_i^{\alpha} S_j^{\beta}, \qquad (1)$$

which describes the topological surface state-mediated exchange coupling $J_{\alpha\beta}(\mathbf{R}_{ij})$ between the classical spins \mathbf{S}_i . Here $\mathbf{R}_{ij} = \mathbf{R}_i - \mathbf{R}_j$ and α, β represent x, y, zspin components. Using second-order perturbation theory in $J_{\rm K}/Wa^2$, where a is the lattice constant of Cr ions, we find $H_{\text{eff}}^{(ij)} = -J_{\text{K}}^2 \sum_{\alpha\beta} \chi_{\alpha\beta}(\mathbf{R}_{ij}) S_{i\alpha} S_{j\beta}$, where $\chi_{\alpha\beta}(\mathbf{R}_{ij})$ is the static spin susceptibility of the surface state electrons. At zero temperature [34], $\chi_{\alpha\beta}(\mathbf{R}_{ij}) =$ $(1/\pi) \operatorname{Im} \int_{-\infty}^{\mu} d\omega \operatorname{Tr} [\sigma_{\alpha} G(\mathbf{R}_{ij}, \omega) \sigma_{\beta} G(-\mathbf{R}_{ij}, \omega)], \text{ where } \mu$ is the chemical potential, the trace is over spin, and $G(\mathbf{R}_{ii}, \omega)$ is the retarded electronic Green's function whose form is known analytically [35, 36]. The integral above can be split into two: the $\int_{-\infty}^{0}$ piece describes virtual interband transitions from the filled valence band, while the \int_0^{μ} piece arises from the Fermi surface of the partially filled conduction band. The latter leads to an oscillatory Ruderman-Kittel-Kasuya-Yosida (RKKY) coupling $\sim \cos(2k_{\rm F}R)/R^2$ for $k_{\rm F}R \gg 1$, where $k_{\rm F}$ is the Fermi wave vector [37, 38].

The first piece, the Bloembergen-Rowland (BR) interaction [39], is ferromagnetic and decays as $1/R^3$ for $a \leq R \ll \hbar v_{\rm F}/\Delta$ and exponentially for $R \gg \hbar v_F/\Delta$. We find [36] that the BR contribution dominates over the RKKY contribution on the distance scale of $R \sim a$ when we are in the low-doping regime $k_F a \ll 1$. We thus neglect the RKKY term and keep the dominant BR coupling.

For simplicity, we assume that the Cr1 and Cr2 sites are the same and this results in a triangular lattice of Cr local moments. We now use the effective Hamiltonian (1) describing spins on a triangular lattice to analyze its properties using several different methods [36].



Figure 5 | Topological surface mediated ferromagnetism of Cr_2Te_3 in the monolayer regime. a Enhancing 2D magnetism via the Bloembergen-Rowland interaction in proximity with a topological insulator. b Hall traces of 1 ML* Cr_2Te_3 at different temperatures from 2 to 300 K. c-d Curie temperature $T_{\rm C}$ determined from the magnetization profile of prestine 1 ML Cr₂Te₃ film (c) and transport data of 1 ML* Cr₂Te₃/4 QL TI (d), namely the anomalous Hall sheet resistance (red) and the coercive field (blue) extracted from b. e.g. Hall traces of 2 ML Cr₂Te₃ (e) and 4 QL BST/2 ML Cr₂Te₃ (g, designated as 2 ML*) at various temperatures. f,h Temperature dependence of the anomalous Hall resistance (red) and coercive field (blue) of 2 ML Cr_2Te_3 (f) and 4 QL BST/2 ML Cr_2Te_3 (h), where TI-induced enhancement in T_C of Cr_2Te_3 is evident.

First, we show that for small clusters of spins, the ground state is ferromagnetic in OOP direction. Next, by computing the spin-wave spectrum in the full lattice model, we found that the spectrum is gapped and of the form $\omega(q) = K + Aq^2$ near q = 0. Here A > 0 is the ferromagnetic exchange stiffness while the gap at q = 0 indicates a PMA of the form $K = f(a\Delta/\hbar v_F) J_K^2 S/\hbar v_F a^3$. We find numerically that the dimensionless function $f \approx 0.15$ when $a\Delta/\hbar v_F$ lies in the realistic range 0 – 0.1. The magnetic anisotropy arises from the anisotropic nature of the BR interaction, which in turn results from the spin-momentum locking of the surface states [40]. The exchange and PMA stabilize an OOP ferromagnetic order at the interface.

We next perform a mean-field calculation for the full lattice Hamiltonian (1), which leads to $T_{\rm C} = [J_{\rm K}^2 S(S+1)/3k_{\rm B}] \sum_{\mathbf{R}} \chi_{zz}(\mathbf{R})$ that is proportional to Van Vleck susceptibility. Using parameters relevant

to the Cr_2Te_3/BST system [37, 38, 41]: S = 3/2, a = 3.93 Å, $v_{\rm F} = 3.69 \times 10^5$ m s⁻¹, $J_{\rm K} \approx 1$ eV·Å², and $\Delta(T \rightarrow T_{\rm C}) \rightarrow 0$, we find $T_{\rm C} \approx 23$ K. We note that this is the $T_{\rm C}$ enhancement arising from the BR interaction. Given the simplicity of our modeling, this result is in reasonable agreement with our experiments. The theoretical framework we have developed should also be applicable to other examples of $T_{\rm C}$ enhancement in TI-proximitized magnets, such as Cr₂Ge₂Te₆ (61 K to 108 K) [42] and Fe₃GeTe₂ (230 K to 400 K) [43].

Conclusion.

The observation of 2D ferromagnetism in monolayerthick Cr_2Te_3 MBE films on insulating $SrTiO_3(111)$ substrates has uncovered a novel atomically thin ferromagnetic insulator candidate capable of strong proximity exchange coupling with other vdW quantum materials such as TI for tunable long range order. In particular, via the BR interaction prevalent when coupling TI to 2D magnets, our comprehensive experimental and theoretical results identify topological surface state proximity as a highly versatile pathway enhancing $T_{\rm C}$ in a wide family of 2D magnets. The interface modulated 2D ferromagnetism in $\rm Cr_2Te_3$ and related magnetic TMC films bodes well for future magnetic topological device design towards all-vdW [44] and molecular [45] spintronics.

METHODS

Sample growth. The samples were grown in an ultrahigh vacuum (UHV) MBE system with a base pressure $< 3.7 \times 10^{-10}$ Torr. The growth was monitored by a RHEED system (STAIB 20) with an electron energy of 15 keV. The $SrTiO_3(111)$ substrate was rinsed in distilled water at 80 °C for 90 minutes and then annealed in a tube furnace at 950 °C with oxygen flow for 3 hours. Before film growth, the substrate was degassed at 500 $^{\circ}$ C for 10 min and then heated at 600 $^{\circ}$ C for 25 min in the MBE chamber. High purity Bi (99.999%), Sb (99.9999%), Te (99.999%), and Cr (99.999%) were co-evaporated from Knudsen cell evaporators and/or e-guns. The flux of each element was monitored by individual quartz crystal monitor during the growth. The growth of Cr_2Te_3 was conducted under Te-rich conditions at a substrate temperature of 235 °C with a typical Te/Cr flux ratio of 10. The BST films were grown under the same Te-rich conditions at a substrate temperature of 235 $^{\circ}C$ with a typical Te/Bi,Sb flux ratio of 10. The Bi/Sb ratio was picked to optimize the resultant chemical potential into the bulk band gap. A 2 nm Te layer and a subsequent 10 nm AlO_x layer were in situ deposited on the films at room temperature to protect the film from possible degradation by air exposure.

Raman spectroscopy. The samples for Raman spectroscopy were capped with in situ grown 10 nm AlO_x . Raman scattering was performed with a custom built, low temperature microscopy setup [46], using a 532 nm excitation laser that has a spot size of 2 μ m in diameter. The spectrometer has a 2400 g mm^{-1} grating, with an Andor CCD, providing a resolution of $\sim 1 \text{ cm}^{-1}$. All data presented in this work were taken at room temperature, and laser heating was minimized using the Stokes to anti-Stokes ratio [47]. Polarization dependence was accomplished by linearly polarizing the excitation laser in the sample plane and rotating the polarization direction via a $\lambda/2$ Fresnel rhomb. A second polarizer was used to analyze the scattered light, which was either parallel (XX) or perpendicular (XY) to the incoming polarization direction. Dark counts were removed by subtracting data collected with the same integration time with the laser blocked. Furthermore, a recently developed wavelet-based approach was employed to remove the effect of cosmic Rays [48].

X-ray characterizations. The XRD patterns were obtained using a parallel beam of Cu $K_{\alpha 1}$ radiation with wavelength $\lambda = 0.15406$ nm in a Rigaku SmartLab system. The 2θ (for OOP measurement) and/or $2\theta_{\chi}$ (for IP configuration) scan angles were typically between 10° and 120° with a step size of 0.05° . XRR measurements were performed at the Center for Nanophase Materials Sciences (CNMS), Oak Ridge National Laboratory, on a PANalytical X'Pert Pro MRD equipped with hybrid monochromator and Xe proportional counter. For the XRR measurements, the X-ray beam was generated at 45 kV/40 mA, and the X-ray beam wavelength after the hybrid mirror was $\lambda = 0.15406$ nm (Cu $K_{\alpha 1}$ radiation).

Scanning transmission electron microscopy. STEM experiments were conducted at a probe-corrected STEM (JEOL ARM) operated at an acceleration voltage of 200 kV. Samples were prepared by a Helios focusedion beam (FEI), operated at an acceleration voltage of 30 kV for the gallium beam during lift-out and of 2 kV during polishing. Additional polishing was performed at 1 kV and 0.5 kV with a NanoMill (Fischione). At both acceleration voltages, samples were polished for 20 min on each side.

Transport and magnetic measurement. Transport measurements were performed in a Quantum Design Physical Property Measurement System (PPMS, 1.9 K, 14 T). The film was manually scratched into a Hall bar geometry. The electrodes were made by mechanically pressing fine indium pieces onto the contact areas of the film. The typical sample size was 500 μ m × 200 μ m. Magnetic properties were measured in a Quantum Design Magnetic Property Measurement System 3 (MPMS3, 1.8 K, 7 T). The typical sample size was 5 mm × 5 mm.

Magnetic force microscopy. The MFM experiments were carried out in a homemade cryogenic atomic force microscope (AFM) using commercial piezoresistive cantilevers (spring constant $k \approx 3$ N m⁻¹, resonant frequency $f_0 \approx 42$ kHz). The homemade AFM is interfaced with a Nanonis SPM Controller using a phase-lock loop (SPECS). MFM tips were prepared by depositing a 150 nm Co film onto bare tips using electron-beam evaporation. MFM images were taken in a constant height mode with the scanning plane ~ 20 nm above sample surface. The MFM signal, the change of the cantilever resonant frequency δf , is proportional to the OOP force gradient acting on the tip, which is a second derivative of the stray field.

Polarized neutron reflectometry. PNR is a highly penetrating depth-sensitive technique to probe the chemical and magnetic depth profiles with a resolution of 0.5 nm. The depth profiles of the NSLD and MSLD correspond to the depth profile of the chemical and IP magnetization vector distributions on the atomic scale, respectively [49–51]. Based on these neutron scattering merits, PNR serves as a powerful technique to simultaneously and nondestructively characterize chemical and

magnetic nature of buried interfaces [52]. PNR experiments were performed on the Magnetism Reflectometer at the Spallation Neutron Source at Oak Ridge National Laboratory [53–56], using neutrons with wavelengths λ in a band of 0.2–0.8 nm and a high polarization of 98.5–99%. Measurements were conducted in a closed cycle refrigerator (Advanced Research System) equipped with a 1.15 T electromagnet (Bruker). Using the time-of-flight method, a collimated polychromatic beam of polarized neutrons with the wavelength band $\delta\lambda$ impinged on the film at a grazing angle θ , interacting with atomic nuclei and the spins of unpaired electrons. The reflected intensity R^+ and R^- were measured as a function of momentum transfer, $Q = 4\pi \sin(\theta)/\lambda$, with the neutron spin parallel (+) or antiparallel (-), respectively, to the applied field. To separate the nuclear from the magnetic scattering, the spin asymmetry ratio $SA = (R^+ - R^-)/(R^+ + R^-)$ was calculated, with SA = 0 designating no magnetic moment in the system. Being electrically neutral, spin-polarized neutrons penetrate the entire multilayer structures and probe magnetic and structural composition of the film and buried interfaces down to the substrate.

Data availability. The data that support the findings of this study are available from the corresponding authors upon reasonable request.

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AUTHOR CONTRIBUTIONS

Y.O., J.S.M. and H.C. conceived the project. The samples were prepared and characterized by Y.O. and H.C.. N.M.N., J.L.M., M.Ro., Y.O. and H.C. performed transport measurements. Y.O., H.C. and D.H. carried out magnetization measurements. A.A. and D.C.B. collected HRSTEM images. W.G. and W.W. obtained MFM images. D.S., Y.W. and K.S.B. performed Raman measurements. J.K. performed XRR measurements, V.L. and H.A. conducted PNR experiments, V.L. analyzed XRR and PNR data. M.M., M.Ra. and N.T. provided theoretical modeling and analysis. Y.O., J.S.M. and H.C. wrote the paper with input from all authors. All authors discussed the results.

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Supplementary Information Enhanced Ferromagnetism in Monolayer Cr₂Te₃ via Topological Insulator Coupling

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Supplementary Figure 1 | X-ray diffraction of 20 monolayer $\operatorname{Cr}_2\operatorname{Te}_3$ film on $\operatorname{SrTiO}_3(111)$. Typical out-of-plane XRD 2θ scan (a), in-plane $2\theta_{\chi}$ scan (b) and ϕ scan (c).



Supplementary Figure 2 | Scanning transmission electron microscopy of Cr_2Te_3 films. a Large scale HRSTEM HAADF image of 13 ML Cr_2Te_3 on SrTiO₃ for the (100) plane. The first ML of Cr_2Te_3 on SrTiO₃ and the TiO_x top layer of SrTiO₃ are indicated by red and yellow. **b-c** FFT of the blue (**b**) and red (**c**) regions as indicated in **a**. **d** HAADF STEM image (left) and the corresponding EDS elemental mapping.



Supplementary Figure 3 | Raman spectroscopy and magnetic force microscopy of Cr_2Te_3 films. a The Raman spectra of Cr_2Te_3 with XX polarization at room temperature. b The polar plot of a representative phonon mode of Cr_2Te_3 . c Temperature dependence of the root-mean-square (RMS) value of the MFM signal. The inset is the MFM image scanned at 5 K with a -1.2 T magnetic field applied along the *c* direction.



Supplementary Figure 4 | Thickness dependent physical properties of $\operatorname{Cr}_2\operatorname{Te}_3$ films. a Thickness dependence of the Curie temperature $T_{\rm C}$ and the inflection point $T_{\rm MIT}$ in resistivity $\rho(T)$, revealing a metal-insulator transition. b Layer dependence of the electrical resistivity of $\operatorname{Cr}_2\operatorname{Te}_3$ films at room temperature. c Layer sensitive relative change in the in-plane lattice parameter a.



Supplementary Figure 5 | Few layer Cr_2Te_3 proximitized with (Bi,Sb)₂Te₃ topological insulator. a Schematic structure of (Bi,Sb)₂Te₃ (BST)/Cr₂Te₃ heterostructure. **b-c** RHEED patterns of 4 QL BST/1 ML Cr₂Te₃ (**b**) and 4 QL BST/2 ML Cr₂Te₃ (**c**) along the [100] direction of Cr₂Te₃.